

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/537,863 FUNAHASHI ET AL.	
		Examiner	Art Unit	Page 1.of 1 Devona E. Faulk 2644

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,031,919	02-2000	Funahashi et al.	381/150
	B	US-5,621,804	04-1997	Beppu, Satoshi	381/332
	C	US-5,929,393	07-1999	Jeter, Jr., Charles W.	181/199
	D	US-6,259,798	07-2001	Perkins et al.	381/397
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 800330 A2	10-1997	European Patent	FUNAHASHI et al.	H04R 01/28
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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